

TMX JT05

SAW Filter datasheet

3.0 x 3.0 x 1.1 mm, SMD

Table of Contents

Features	1
Maximum Ratings	1
Frequency and Electrical Characteristics (Reference temperature @ 25°C)	1
Model Outline, Pin Connection and Marking	2
Test Circuit	2
Frequency Characteristics	3
Recommended Reflow Soldering Profile	4
Tape and Reel Specifications	5
Reliability Test	6



Features

Fe	atı	ures	5
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- 763.5 MHz center frequency
- Ceramic package for Surface Mounted Technology
- Typical Passband width: 17.25 MHz
- Low loss RF fitler and low amplitude ripple
- No matching network required for operation at 50 Ω

Applications

Wireless applications



Maximum Ratings

Parameter	Min.	Тур.	Max.	Unit
Storage temperature range (T _{stg})	-40		85	°C
Operating temperature range (T_A)	-40		85	°C
DC voltage			12	V
RF Power (in band width)			15	dBm

Frequency and Electrical Characteristics (Reference temperature @ 25°C)

Parameter	Min.	Typ.1	Max.	Unit
Center frequency (f _c)		763.5		MHz
Bandwidth (BW, passband width)		17.25		MHz
Insertion Loss (IL, 754.875 – 772.125 MHz)		2.5	3.0	dB
Passband ripple (pk-pk) (754.875 – 772.125 MHz)		0.8	1.2	dB
Absolute Attenuation				
From DC to (fc - 471) MHz	50	72		
From 471 to 571 MHz	50	70		
From 571 to 711 MHz	30	52		
From 711 to 731 MHz	30	50		dB
From 796 to 820 MHz	30	40		ив
From 820 to 831 MHz	35	55		
From 831 to 971 MHz	40	52		
From 971 to 1071 MHz	40	48		
From 1071 to 2000 MHz	10	19		
VSWR (754.875 – 772.125 MHz)		1.6	2.0	
Source impedance ² (Single ended)		50		Ω
Load impedance ² (Single ended)		50		Ω

² No external matching is required

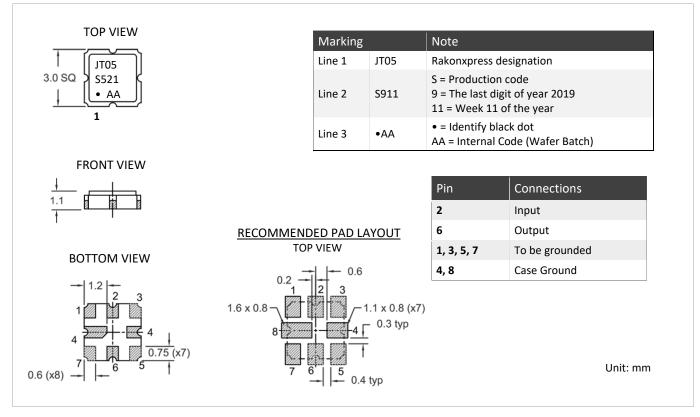
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¹ Typical values are nominal performances at room temperature

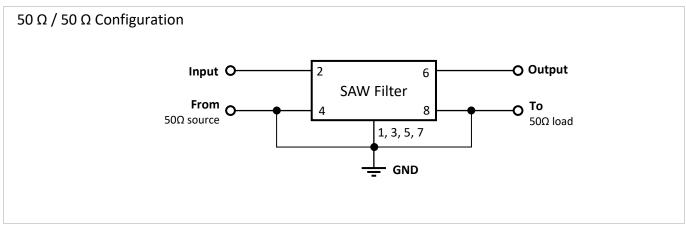


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Model Outline, Pin Connection and Marking



Test Circuit

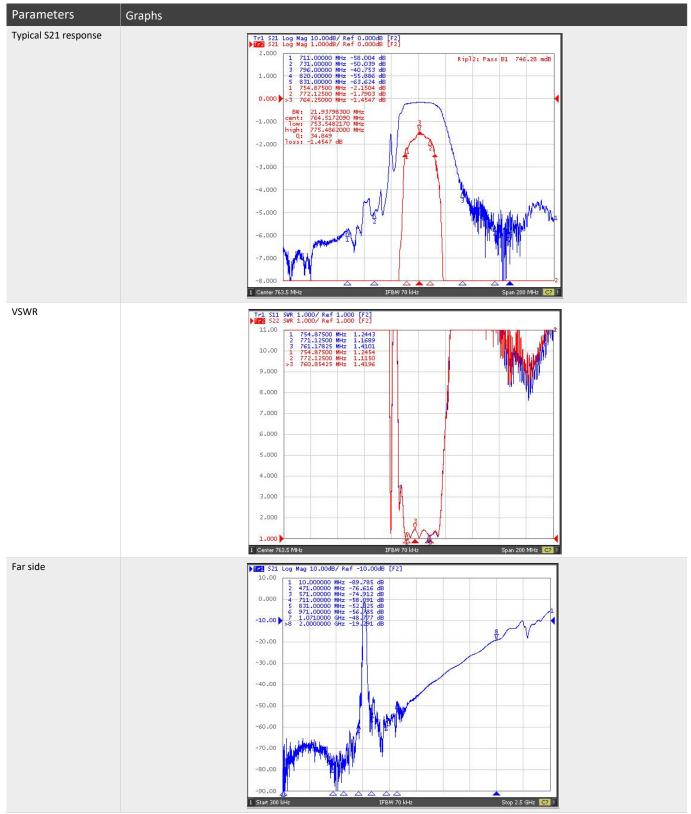




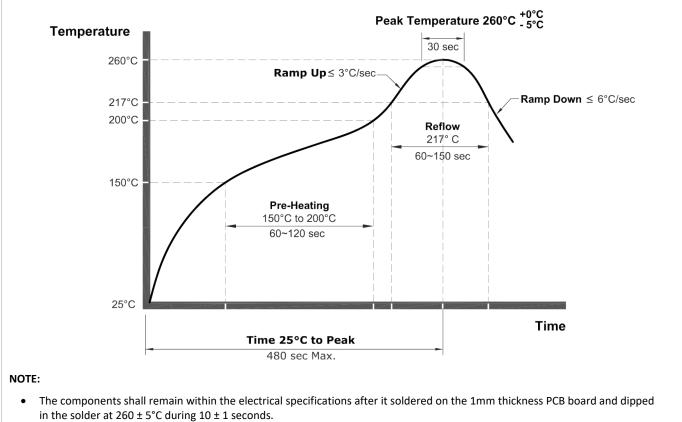
TMX JT05

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Frequency Characteristics







Recommended Reflow Soldering Profile

 The components shall remain within the electrical specifications after it soldered by electric iron, solder at 350 ± 10 °C during 3~4 seconds. Recovery time: 2 ± 0.5 hour.

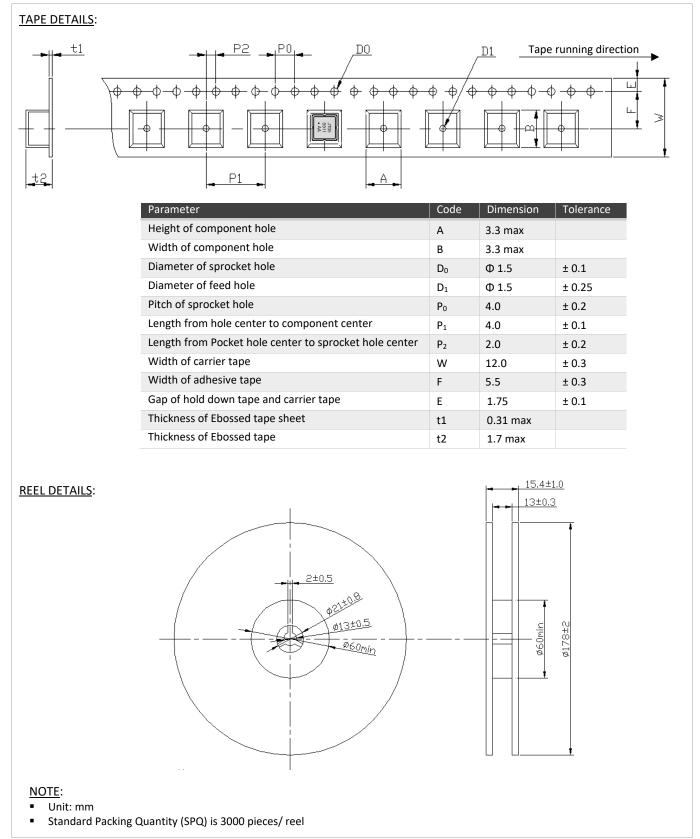
- Ultrasonic cleaning may cause deterioration and destruction of the component. Please avoid ultrasonic cleaning.
- Only leads of components may be soldered. Please avoid soldering another part of the component.

TMX JT05



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Tape and Reel Specifications





Reliability Test

Parameter	Test condition / Description
Thermal Shock	The components shall remain within the electrical specifications after being kept at the condition of heat cycle conditions: TA=-40° C \pm 3° C, TB=85° C \pm 2° C, t1=t2=30min, switch time \leq 3min & cycle time: 100 times, recovery time: 2h \pm 0.5h.
Temperature Storage	High Temperature Storage: The components shall remain within the electrical specifications after being kept at the 85°C \pm 2°C for 500 hours, recovery time: 2h \pm 0.5h. Low Temperature Storage: The components shall remain within the electrical specifications after being kept at the -40°C \pm 3°C for 500 hours, recovery time: 2h \pm 0.5h.
Humidity test	The components shall remain within the electrical specifications after being kept at the condition of ambient temperature $60^{\circ}C \pm 2^{\circ}C$, and $90^{\sim}95\%$ RH for 500 hours.
Drop test	The components shall remain within the electrical specifications after random free drops 10 times from height of 1.0 meter onto concrete floor, and the specimens shall meet the electrical specifications.
Vibration Fatigue	The components shall remain within the electrical specifications after loaded vibration at 10~55Hz, amplitude 1.5mm, X, Y, Z, direction, during 2 hours.
Mechanical Shock	The components shall remain within the electrical specifications after 1000 shocks, acceleration 392 $\rm m/s^2$, duration 6ms.
Note	As a result of the particularity of inner structure of SAW products, the components can easily be breakdown by electrostatic shock; so it's mandatory to pay attention to ESD protect during the tests.